PLESSEY
Semiconductors

SP1672

TRIPLE 2-INPUT EXCLUSIVE-OR GATE

This three gate array is designed to provide the positive logic Exclusive-OR function in high speed applications. These devices contain a temperature compensated internal bias which insures that the threshold point remains in the centre of the transition region over the temperature range (-30°C to +85°C). Input pulldown resistors eliminate the need to tie unused inputs to V_{EE}.

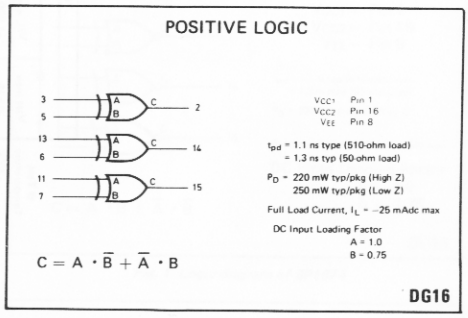

Fig. 1 Logic diagram of SP1672

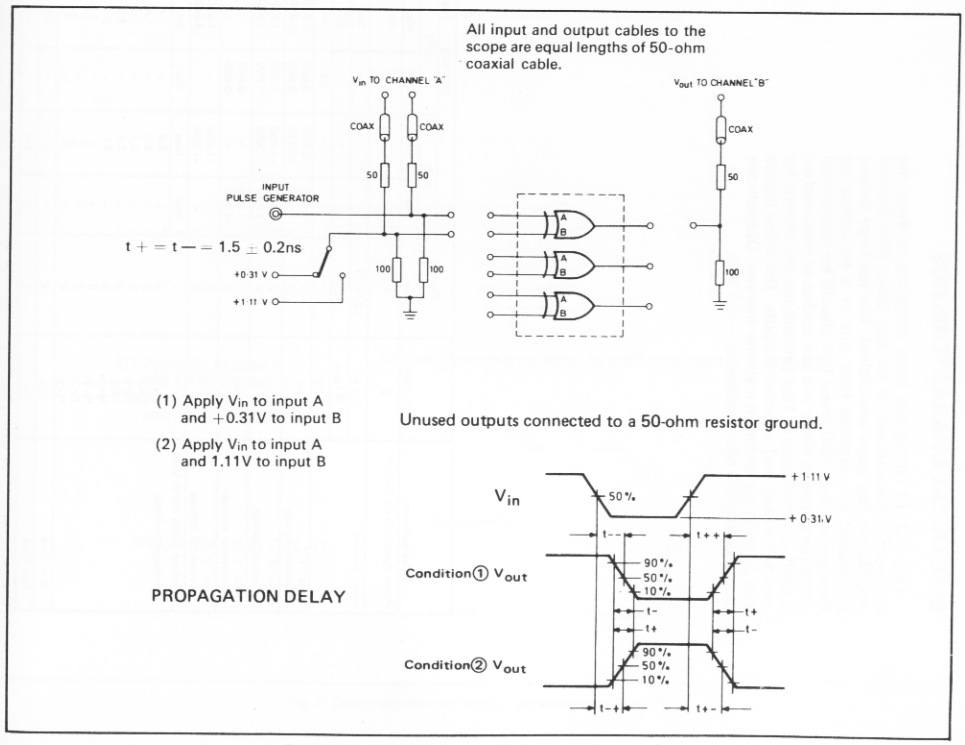

Fig. 2 Switching time test circuit and waveforms at +25°C

ELECTRICAL CHARACTERISTICS

This ECL III circuit has been designed to meet the dc specifications shown in the test table, after thermal equiblirium has been established. The package should be housed in a suitable heat sink or a transverse air flow greater than 500 linear fpm should be maintained while the circuit is either in a test socket or mounted on a printed circuit board. Test procedures are shown for selected inputs and selected outputs. The other inputs and outputs are tested in a similar manner. Outputs are tested with a 50-ohm resistor to −2.0 Vdc.

@ Test Temperature	TEST VOLTAGE VALUES (Volts) $V_{IH\ max}$	$V_{IL\ min}$	$V_{IHA\ min}$	$V_{ILA\ max}$	V_{EE}
-30°C	-0.875	-1.890	-1.180	-1.515	-5.2
+25°C	-0.810	-1.850	-1.095	-1.485	-5.2
+85°C	-0.700	-1.830	-1.025	-1.440	-5.2

Characteristic	Symbol	Pin Under Test	SP1672 Test Limits -30°C Min	-30°C Max	+25°C Min	+25°C Max	+85°C Min	+85°C Max	Unit	TEST VOLTAGE APPLIED TO PINS LISTED BELOW: $V_{IH\ max}$	$V_{IL\ min}$	$V_{IHA\ min}$	$V_{ILA\ max}$	V_{EE}	(V_{CC}) Gnd
Power Supply Drain Current	I_E	8	–	–	–	55	–	–	mAdc	All Inputs	–	–	–	8	1,16
Input Current	$I_{in\ H}$	3,11,13	–	–	–	350	–	–	μAdc	*	–	–	–	8	1,16
	0.75 $I_{in\ H}$	5,6,7	–	–	–	270	–	–	μAdc	*	–	–	–	8	1,16
	$I_{in\ L}$	*	–	–	0.5	–	–	–	μAdc	–	*	–	–	8	1,16
Logic "1" Output Voltage	V_{OH}	2	-1.045	-0.875	-0.960	-0.810	-0.890	-0.700	Vdc	3	5	–	–	8	1,16
		2	-1.045	-0.875	-0.960	-0.810	-0.890	-0.700	Vdc	5	3	–	–	8	1,16
Logic "0" Output Voltage	V_{OL}	2	-1.890	-1.650	-1.850	-1.620	-1.830	-1.575	Vdc	3,5	–	–	–	8	1,16
		2	-1.890	-1.650	-1.850	-1.620	-1.830	-1.575	Vdc	–	3,5	–	–	8	1,16
Logic "1" Threshold Voltage	V_{OHA}	2	-1.065	–	-0.980	–	-0.910	–	Vdc	–	–	3	5	8	1,16
		2	-1.065	–	-0.980	–	-0.910	–	Vdc	–	–	5	3	8	1,16
Logic "0" Threshold Voltage	V_{OLA}	2	–	-1.630	–	-1.600	–	-1.555	Vdc	–	–	3,5	–	8	1,16
		2	–	-1.630	–	-1.600	–	-1.555	Vdc	–	–	–	3,5	8	1,16
Switching Times (50 Ω Load)			Min	Max	Min	Max	Min	Max				Pulse In	Pulse Out	-3.2 V	+2.0 V
Propagation Delay	t_{3+2+}	2	–	2.0	–	1.8	–	2.3	ns	–	–	3	2	8	1,16
	t_{3-2+}	2	–	2.0	–	1.8	–	2.3		–	–				
	t_{3+2-}	2	–	2.1	–	1.9	–	2.4		–	–				
	t_{3-2-}	2	–	2.1	–	1.9	–	2.4		–	–				
	t_{5+2+}	2	–	2.5	–	2.3	–	2.8		–	–	5			
	t_{5-2+}	2	–		–		–			–	–				
	t_{5+2-}	2	–		–		–			–	–				
	t_{5-2-}	2	–		–		–			–	–				
Rise Time	t_{2+}	2	–	2.7	–	2.5	–	2.9	ns	–	–	3	2	8	1,16
Fall Time	t_{2-}	2	–	2.4	–	2.2	–	2.6	ns	–	–	3	2	8	1,16

*Individually test each input applying V_{IH} or V_{IL} to input under test.